





20V COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

Device	V _{(BR)DSS}	R _{DS(on)} max	I _D Max T _A = 25°C (Notes 3 & 5)
Q1	20V	20mΩ @ V _{GS} = 4.5V	8.5A
		$28mΩ @ V_{GS} = 2.5V$	7.2A
Q2	-20V	33mΩ @ V _{GS} = -4.5V	-6.8A
		45mΩ @ V _{GS} = -2.5V	-5.8A

Description and Applications

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

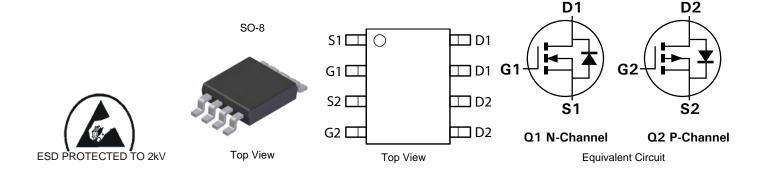
- Motor control
- DC-DC Converters
- Power management functions
- Notebook Computers and Printers

Features and Benefits

- Reduced footprint with two discretes in a single SO8
- Low gate drive
- Low input capacitance
- · Fast Switching Speed
- Low Input/Output Leakage
- . ESD Protected up to 2kV
- "Lead Free", RoHS Compliant (Note 1)
- Halogen and Antimony Free. "Green" Device (Note 1)

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper lead frame.
 Solderable per MIL-STD-202, Method 208
- Weight: 0.074 grams (approximate)

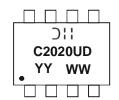


Ordering Information (Note 1)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMC2020USD-13	C2020UD	13	12	2,500

Notes: 1. No purposefully added lead. Diodes Inc.'s "Green" policy and packaging details can be found on our website at http://www.diodes.com.

Marking Information



Oll = Manufacturer's Marking C2020UD = Product Type Marking Code YYWW = Date Code Marking YY = Year (ex: 09 = 2009) WW = Week (01 - 53)





Maximum Ratings @T_A = 25°C unless otherwise specified

	Characteristic		Symbol	N-Channel - Q1	P-Channel - Q2	Units
Drain-Source Voltage	V _{DSS}	20	-20	V		
Gate-Source Voltage			V _{GSS}	±10	±10	V
		(Notes 3 & 5)	I _D	8.5	-6.8	A
Continuous Drain Current	V _{GS} = 4.5V	T _A = 70°C (Notes 3 & 5)		6.8	-5.4	
Continuous Drain Current		(Notes 2 & 5)		6.5	-5.2	
		(Notes 2 & 6)		7.8	-6.3	
Pulsed Drain Current V _{GS} = 4.5V		(Notes 4 & 5)	I _{DM}	33.6	-26.8	
Continuous Source Current (Body diode) (Notes 3 & 5		(Notes 3 & 5)	Is	4.0	-4.0	
Pulsed Source Current (Body diode) (Notes 4 & 5)		(Notes 4 & 5)	I _{SM}	33.6	-26.8	

Thermal Characteristics @T_A = 25°C unless otherwise specified

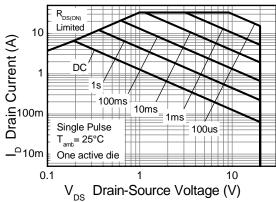
Characteristic	Symbol	N-Channel - Q1	P-Channel - Q2	Unit		
	(Notes 2 & 5)		1.2			
Power Dissipation Linear Derating Factor	(Notes 2 & 6)	P _D	1.8 14.3		W mW/°C	
	(Notes 3 & 5)		2.14 17.2			
	(Notes 2 & 5)		100 R _{0JA} 70		°C/W	
Thermal Resistance, Junction to Ambient	(Notes 2 & 6)	R _{0JA}				
	(Notes 3 & 5)		58			
Thermal Resistance, Junction to Lead	(Notes 5 & 7)	R ₀ JL	51		1	
Operating and Storage Temperature Range	T _J , T _{STG}	-55 to	+150	°C		

Notes:

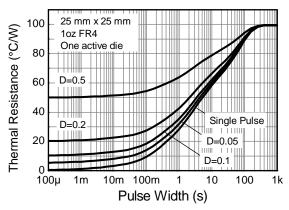
- 2. For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.
- 3. Same as note (2), except the device is measured at $t \le 10$ sec.
- 4. Same as note (2), except the device is pulsed with D = 0.02 and pulse width 300 μ s.
- 5. For a dual device with one active die.
- 6. For a device with two active die running at equal power.
- 7. Thermal resistance from junction to solder-point (at the end of the drain lead).



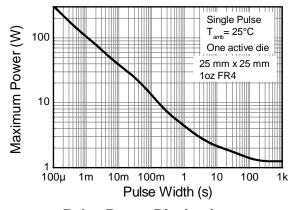
Thermal Characteristics



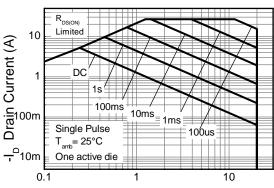
N-channel Safe Operating Area



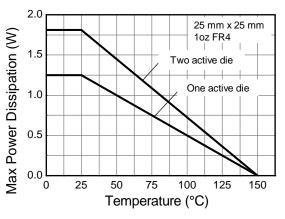
Transient Thermal Impedance



Pulse Power Dissipation



-V_{DS} Drain-Source Voltage (V) **P-channel Safe Operating Area**



Derating Curve



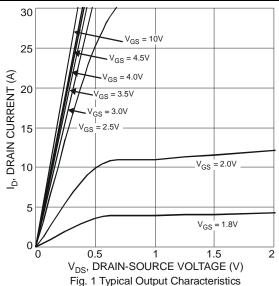
Electrical Characteristics – Q1 N-CHANNEL @TA = 25°C unless otherwise specified

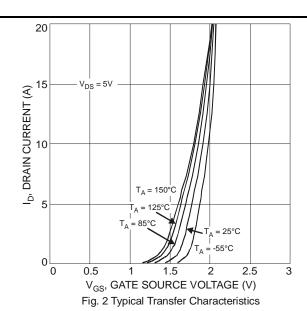
Characteristic		Min	Тур	Max	Unit	Test C	ondition	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV _{DSS}	20	-	-	V	$V_{GS} = 0V$, $I_D = 2$	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	1.0	μΑ	$V_{DS} = 20V, V_{GS}$; = 0V	
Gate-Source Leakage	I _{GSS}	-	-	±10	μΑ	$V_{GS} = \pm 10V, V_{D}$	os = 0V	
ON CHARACTERISTICS								
Gate Threshold Voltage	V _{GS(th)}	0.5	1.1	1.5	V	$V_{DS} = V_{GS}, I_{D} =$	250μΑ	
Static Drain-Source On-Resistance (Note 8)	D		13	20	mΩ	$V_{GS} = 4.5V, I_{D} = 4.5V$	= 7A	
Static Drain-Source Off-Resistance (Note 8)	R _{DS (ON)}	-	18	28	11122	$V_{GS} = 2.5V, I_D = 3A$		
Forward Transfer Admittance (Notes 8 & 9)	Y _{fs}	-	16	-	S	$V_{DS} = 5V, I_{D} = 9$	9.4A	
Diode Forward Voltage (Note 8)	V_{SD}	-	0.7	1.2	V	$V_{GS} = 0V$, $I_S = 0$	1.3A	
Continuous Source Current	Is	-	-	1.8	Α	-		
DYNAMIC CHARACTERISTICS (Note 9)								
Input Capacitance	Ciss	-	1149	-		\/ 40\/ \/	0)/	
Output Capacitance	Coss	-	157	-	pF	$V_{DS} = 10V, V_{GS}$ f = 1.0MHz	$\varsigma = 0 V$,	
Reverse Transfer Capacitance	C _{rss}	-	142	-		1 = 1.0101112		
Gate Resistance	Rg	-	1.51	-	Ω	$V_{DS} = 0V, V_{GS} = 0$	= 0V, f = 1MHz	
Total Gate Charge (Note 10)	Q_{g}	-	6.0	-		$V_{GS} = 2.5V$		
Total Gate Charge (Note 10)	Q_g	-	11.6	-			101/	
Gate-Source Charge (Note 10)	Q_{gs}	-	2.7	-	nC	\/ 4.5\/	$V_{DS} = 10V$	
Gate-Drain Charge (Note 10)	Q_{gd}	-	3.4	-		$V_{GS} = 4.5V$ $I_{D} = 9.4A$		
Turn-On Delay Time (Note 10)	t _{D(on)}	-	11.67	-				
Turn-On Rise Time (Note 10)	t _r	-	12.49	-		Vac = 4.5V, Vac = 10V		
Turn-Off Delay Time (Note 10)	t _{D(off)}	-	35.89	-	ns	$V_{GS} = 4.5V, V_{DS} = 10V,$		
Turn-Off Fall Time (Note 10)	t _f	-	12.33	-		$R_G = 6\Omega$, $I_D = 1A$		

Notes:

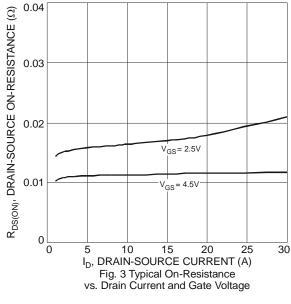
- 8. Measured under pulsed conditions. Pulse width $\leq 300 \mu s;$ duty cycle $\leq 2\%$
- 9. For design aid only, not subject to production testing.
- 10. Switching characteristics are independent of operating junction temperatures.

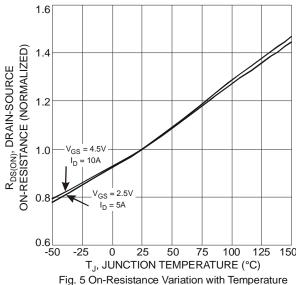
Typical Characteristics – Q1 N-CHANNEL











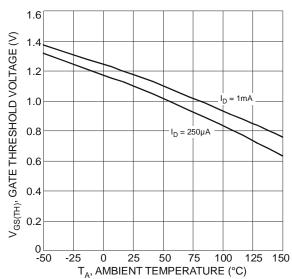


Fig. 7 Gate Threshold Variation vs. Ambient Temperature

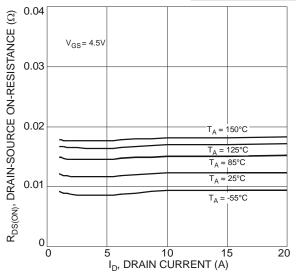


Fig. 4 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

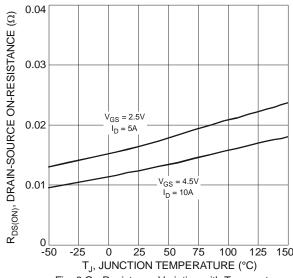


Fig. 6 On-Resistance Variation with Temperature

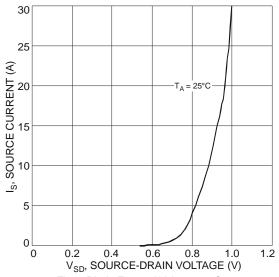
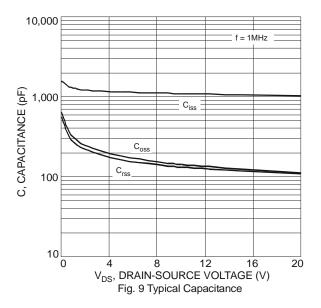
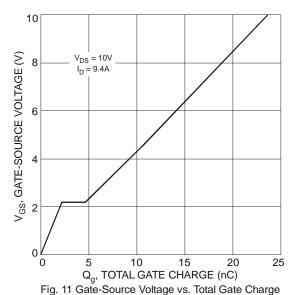
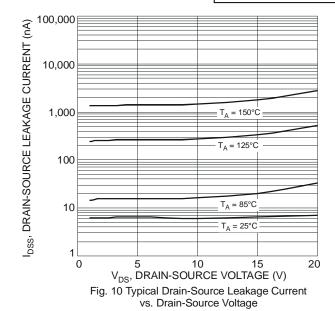


Fig. 8 Diode Forward Voltage vs. Current











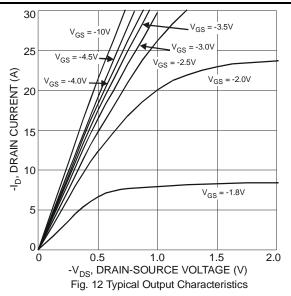
Electrical Characteristics – Q2 P-CHANNEL @TA = 25°C unless otherwise specified

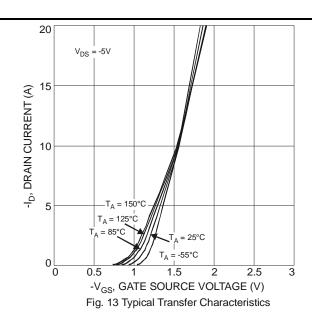
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS		•		•	•		
Drain-Source Breakdown Voltage	BV _{DSS}	-20	-	-	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	-	-	-1.0	μΑ	$V_{DS} = -20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±10	μΑ	$V_{GS} = \pm 10V$, $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	$V_{GS(th)}$	-0.4	-0.7	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance (Note 11)			26	33	mΩ	$V_{GS} = -4.5V$, $I_D = -6A$	
Static Drain-Source On-Resistance (Note 11)	R _{DS (ON)}	-	33	45	mr7	$V_{GS} = -2.5V, I_D = -3A$	
Forward Transfer Admittance (Note 11 & 12)	Y _{fs}	-	14	-	S	$V_{DS} = -5V, I_{D} = -4A$	
Diode Forward Voltage (Note 11)	V_{SD}	-	-0.7	-1.0	V	$V_{GS} = 0V, I_{S} = -1A$	
Continuous Source Current	I _S	-	-	-1.8	Α	-	
DYNAMIC CHARACTERISTICS (Note 12)						_	
Input Capacitance	C _{iss}	-	1610	-		101/1/	
Output Capacitance	Coss	-	157	-	pF	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	-	145	-		1 – 1.01/11/12	
Gate Resistance	Rg	-	9.45	-	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (Note 13)	Qg	-	8.0	-		V _{GS} = -2.5V	
Total Gate Charge (Note 13)	Qg	-	15.4	-	nC	V _{DS} = -10V	
Gate-Source Charge (Note 13)	Q _{gs}	-	2.5	-	iiC	$V_{GS} = -4.5V$ $I_{D} = -4A$	
Gate-Drain Charge (Note 13)	Q _{qd}	-	3.3	-			
Turn-On Delay Time (Note 13)	t _{D(on)}	-	16.8	-		T	
Turn-On Rise Time (Note 13)	t _r	-	12.4	-		$V_{GS} = -4.5V, V_{DS} = -10V,$	
Turn-Off Delay Time (Note 13)	t _{D(off)}	-	94.1	-	ns	$R_G = 6\Omega$, $I_D = -1A$	
Turn-Off Fall Time (Note 13)	t _f	-	42.4	-			

Notes:

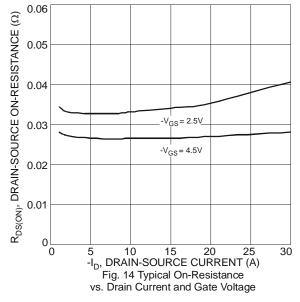
- 11. Measured under pulsed conditions. Pulse width $\leq 300 \mu s;$ duty cycle $\leq 2\%$
- 12. For design aid only, not subject to production testing.13. Switching characteristics are independent of operating junction temperatures.

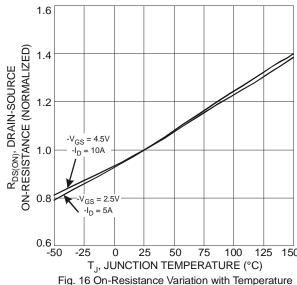
Typical Characteristics - Q2 P-CHANNEL











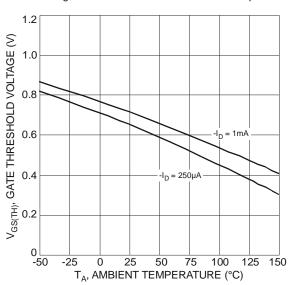


Fig. 18 Gate Threshold Variation vs. Ambient Temperature

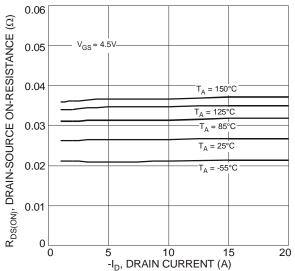


Fig. 15 Typical Drain-Source On-Resistance vs. Drain Current and Temperature

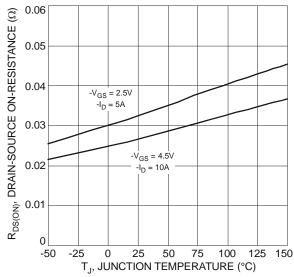


Fig. 17 On-Resistance Variation with Temperature

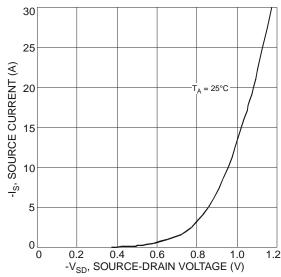
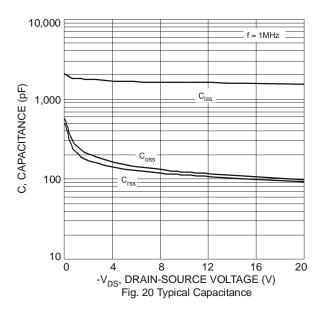
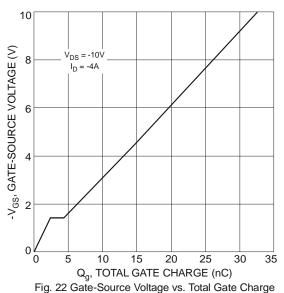
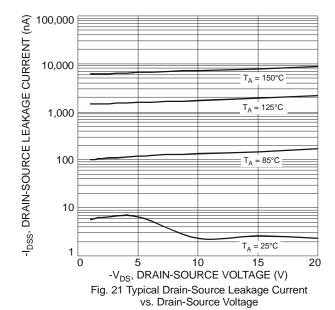


Fig. 19 Diode Forward Voltage vs. Current



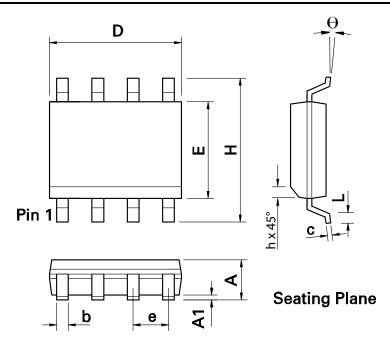






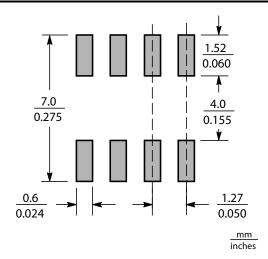


Package Outline Dimensions



DIM	Inc	Inches		Millimeters		Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	θ	0°	8°	0°	8°
Е	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	-

Suggested Pad Layout







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